Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/717,497	SAINT ETIENNE ET AL.

Examiner

Albert T. Chou

E ET AL. Art Unit

2616

SEARCHED					
Class	Subclass	Date	Examiner		
370	276	6/12/2007	Ac		
370	4	6/12/2007	Ac		
370	221	6/12/2007	Ac		
370	224 .	6/12/2007	Ac		
370	228	6/12/2007	Ac		
714	6	6/12/2007	Ac		
714	11	6/12/2007	Ac		
714	717	6/12/2007	AC		

INTERFERENCE SEARCHED					
Subclass	Date	Examiner			

(INCLUDING SEAI	RCH STRATEGY	SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR			
Inventor Search - EAST	6/12/2007	AC			
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